

PCTEST ENGINEERING LABORATORY, INC.

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HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics MobileComm U.S.A, Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: May 27-28, 2014 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1405161020.ZNF

FCC ID:

ZNFB460

APPLICANT:

LG ELECTRONICS MOBILECOMM U.S.A, INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard: EUT Type: Model(s): Test Device Serial No.:

Audio Band Magnetic Testing (T-Coil) Certification CFR §20.19(b) ANSI C63.19-2011 Portable Handset LG-B460, LGB460, B460, LG441G *Pre-Production Sample* [S/N: 86]

C63.19-2011 HAC Category:

T4 (SIGNAL TO NOISE CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- **RF** Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode .

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. TEST SITE

I. Test Facility / Accreditations:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), Long-Term Evolution (LTE), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
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- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
 - PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and all Industry Canada Standards (RSS).
 - PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.

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EUT DESCRIPTION 3.



FCC ID:	ZNFB460
Applicant:	LG Electronics MobileComm U.S.A, Inc.
	1000 Sylvan Avenue
	Englewood Cliffs, NJ 07632
	United States
Model(s):	LG-B460, LGB460, B460, LG441G
Serial Number:	86
HW Version:	1.0
SW Version:	LGB460-V08d-APR-11-2014
Antenna:	Internal Antenna
HAC Test Configurations:	GSM 850, 128, 190, 251, BT Off
	GSM 1900, 512, 661, 810, BT Off
	UMTS V, 4132, 4183, 4233, BT Off
	UMTS II, 9262, 9400, 9538, BT Off
EUT Type:	Portable Handset

EUI Type:

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Voice over Digital Transport OTT Capability	WIFI Low Power	Additional GSM Power Reduction
	850	vo	Yes	Yes: BT	N/A		
GSM	1900	VO	res	Tes. DI	N/A	N/A	No
	GPRS	DT	No	Yes: BT	No		
	850	VD	Yes	Yes: BT	N/A		
UMTS	1900	VD	Tes	1es. DI	N/A	N/A	N/A
	HSDPA	DT	No	Yes: BT	No		
BT	2450	DT	No	Yes: GSM or UMTS	N/A	N/A	N/A
Type Transport							

VD = Voice Only DT = Digital Data - Not intended for CMRS Service VD = CMRS and Data Transport

Table 3-1: ZNFB460 HAC Air Interfaces

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ANSI C63.19-2011 PERFORMANCE CATEGORIES 4.

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be \geq -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz - 3000 Hz per §8.3.2.

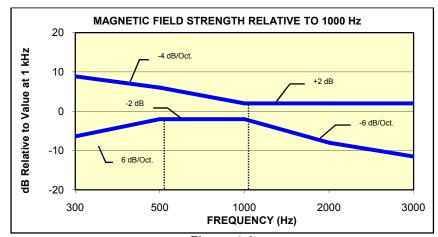


Figure 4-1 Magnetic field frequency response for Wireless Devices with an axial field ≤-15 dB (A/m) at 1 kHz

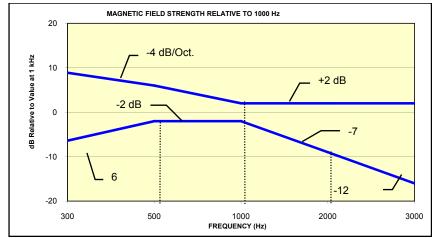


Figure 4-2

Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

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Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Category	Telephone RF Parameters			
	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]			
T1	0 to 10 dB			
T2	10 to 20 dB			
Т3	20 to 30 dB			
T4	> 30 dB			
Table 4-1 Magnetic Coupling Parameters				

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METHOD OF MEASUREMENT 5.

I. **Test Setup**

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

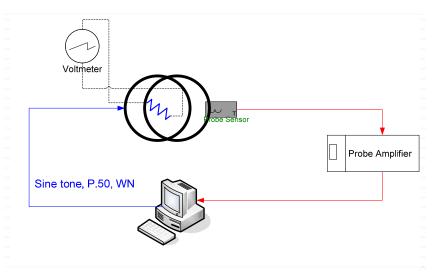
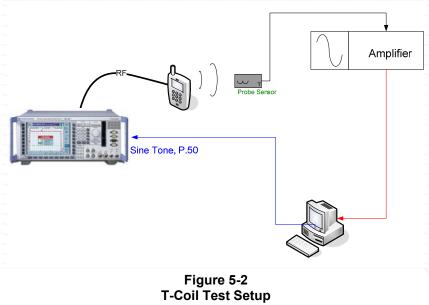


Figure 5-1 Validation Setup with Helmholtz Coil



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II. Scanning Mechanism

Manufacturer:	TEM
Accuracy:	± 0.83 cm/meter
Minimum Step Size:	0.1 mm
Maximum speed	6.1 cm/sec
Line Voltage:	115 VAC
Line Frequency:	60 Hz
Material Composite:	Delrin (Acetal)
Data Control:	Parallel Port
Dynamic Range (X-Y-Z):	45 x 31.75 x 47 cm
Dimensions:	36" x 25" x 38"
Operating Area:	36" x 49" x 55"
Reflections:	< -20 dB (in anechoic chamber)

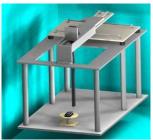


Figure 5-3 RF Near-Field Scanner

III. ITU-T P.50 Artificial Voice

Manufacturer:	
Active Frequency	
Range:	
Stimulus Type:	
Single Sample	
Duration:	
Activity Level:	

ITU-T	
100 Hz – 8 kHz	
Male and Female, no spaces	
20.96 seconds	
100%	

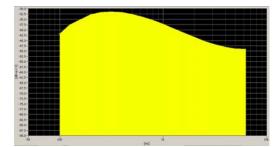


Figure 5-4 Spectral Characteristic of full P.50

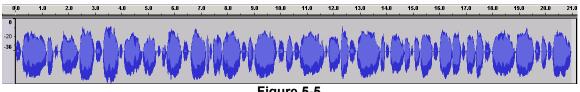
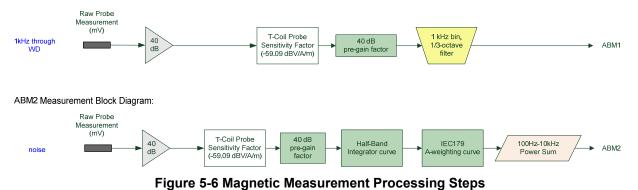


Figure 5-5 Temporal Characteristic of full P.50

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ABM1 Measurement Block Diagram:



IV. **Test Procedure**

- 1. Ambient Noise Check per C63.19 §7.3.1
 - Ambient interference was monitored using a Real-Time Analyzer between100-10.000 Hz а with 1/3 octave filtering.
 - "A-weighting" and Half-Band Integration was applied to the measurements. b.
 - Since this measurement was measured in the same method as ABM2 measurements, С this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is: -18 - 30 - 10= -58 dBA/m

- Measurement System Validation(See Figure 5-1) 2.
 - The measurement system including the probe, pre-amplifier and acquisition system were a. validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation

The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter N = number of turns per coil

For the Helmholtz Coil, N=20; r=0.13m; R=10.193Ω and using V=29mV:

$$H_{c} = \frac{20 \cdot (\frac{0.029}{10.193})}{0.13 \cdot \sqrt{1.25^{3}}} = 0.31623A / m \approx -10dB(A / m)$$

Therefore a pure tone of 1kHz was applied into the coils such that 29 mV was observed across the 10 Ω resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of -10 dB(A/m) in the center of the Helmholtz coil which was used to validate the probe measurement at -10dB(A/m). This was verified to be within ± 0.5 dB of the -10dB(A/m) value (see Page 23).

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c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1kHz, between 300 - 3000 Hz using the Normal speech signal as shown below:

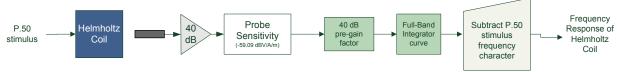


Figure 5-7 Frequency Response Validation

d. ABM2 Measurement Validation

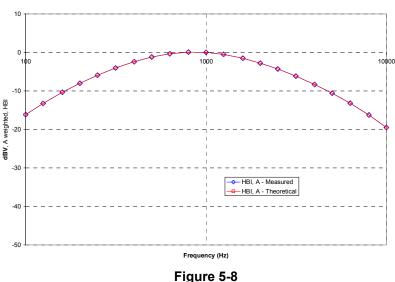
WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz - 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

ABM2 Frequency Response Validation					
	HBI, A -	HBI, A -			
f (Hz)	Measured	Theoretical	dB Var.		
	(dB re 1kHz)	(dB re 1kHz)			
100	-16.180	-16.170	-0.010		
125	-13.257	-13.250	-0.007		
160	-10.347	-10.340	-0.007		
200	-8.017	-8.010	-0.007		
250	-5.925	-5.920	-0.005		
315	-4.045	-4.040	-0.005		
400	-2.405	-2.400	-0.005		
500	-1.212	-1.210	-0.002		
630	-0.349	-0.350	0.001		
800	0.071	0.070	0.001		
1000	0.000	0.000	0.000		
1250	-0.503	-0.500	-0.003		
1600	-1.513	-1.510	-0.003		
2000	-2.778	-2.780	0.002		
2500	-4.316	-4.320	0.004		
3150	-6.166	-6.170	0.004		
4000	-8.322	-8.330	0.008		
5000	-10.573	-10.590	0.017		
6300	-13.178	-13.200	0.022		
8000	-16.241	-16.270	0.029		
10000	-19.495	-19.520	0.025		

	Table 5-1					
ABM	ABM2 Frequency Response Validation					

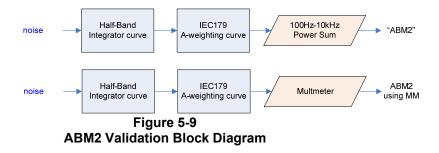
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ABM2 Frequency Response Validation (LISTEN)



ABM2 Frequency Response Validation

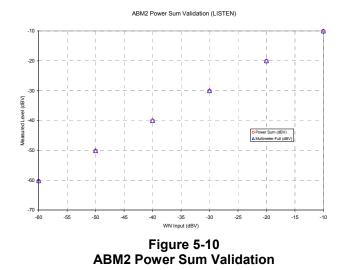
The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and Aweighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 5-9). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:



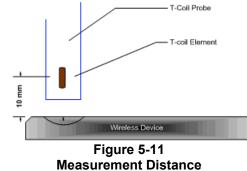
The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

		A	Table 5-2 ABM2 Power Sum Validation		
		WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
		-60	-60.36	-60.2	0.16
		-50	-50.19	-50.13	0.06
		-40	-40.14	-40.03	0.11
		-30	-30.13	-30.01	0.12
		-20	-20.12	-20	0.12
		-10	-10.14	-10	0.14
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- 3. Measurement Test Setup
 - a. Fine scan above the WD (TEM)
 - i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below:



- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the sound check system.
- iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 5-16 after a T-coil orientation was fully measured with the SoundCheck system.
- b. Speech Signal Setup to Base Station Simulator
 - i. C63.19 Table 7-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
	TDMA (22 and 11 Hz)	-18

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The CMU200 audio levels were determined using base station simulator manufacturer calibration procedures resulting in the below corresponding voltages relative to handset test point level (in dBm0):

dBm0 Ref Voltage Notes From GSM "DECODER CAL". 3.14 dBm0 990.5 mV -0.08 dBV (What is needed through Encoder for FS) -16 dBm0 109.4 mV -19.2 dBV For Speechcod/Handset Low dBm0 Ref. Voltage Notes From UMTS "DECODER CAL". 3.14 dBm0 1068.5 mV 0.58 dBV (What is needed through Encoder for FS) -16 dBm0 118.0 mV -18.6 dBV For Handset Low

Table 5-3 CMU200 Voltage Input Levels for Audio

- c. Real-Time Analyzer (RTA)
 - i. The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition under EFR (GSM); AMR 12.2 kbps (UMTS); (see below):

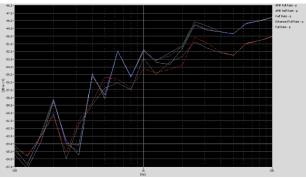


Figure 5-12 Vocoder Analysis for ABM Noise

- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 4-1 or Figure 4-2between 300 - 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.

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ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 5-13. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.

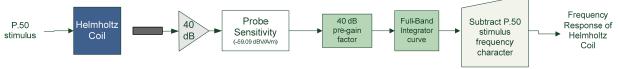
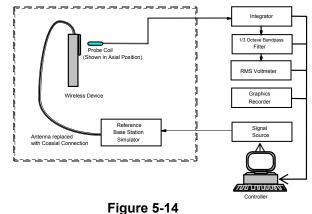


Figure 5-13 Frequency Response Block Diagram

- iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
- c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight on, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - iii. This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

V. Test Setup



Audio Magnetic Field Test Setup

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection due to RF port being located beneath the battery.

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VII. Air Interface Technologies Tested

All 3G packet services were not tested for this device since they are considered 'Over-the-Top' applications and are not within the current definition of a managed CMRS service.

VIII. Wireless Device Channels and Frequencies

The frequencies listed in the table below are those that lie in the center of the bands used for cellular telephony. Low, middle and high channels were tested in each band for FCC compliance evaluation to ensure the maximum emission is captured across the entire band.

To facilitate setting of a base station simulator for ABM measurements, specific band plan channel numbers are listed that may be used in lieu of the band center frequencies.

Center Channels and Frequencies					
Test frequencies & associated channels					
Channel Frequency (MHz)					
Cellular 850					
190 (GSM)	836.60				
4183 (UMTS)	836.60				
PCS 1900					
661 (GSM)	1880				
9400 (UMTS)	1880				

 Table 5-4

 Center Channels and Frequencies

IX. RF Emission Effect on T-coil Measurements

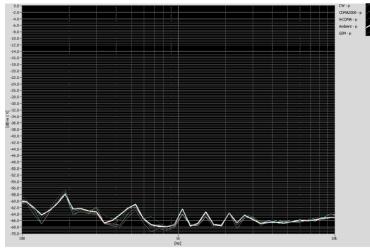


Figure 5-15 High power RF Emissions Effect with HAC Dipole on the T-coil Probe System 10mm between dipole maximum and magnetic probe

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Х. **Test Flow**

The flow diagram below was followed (From C63.19):

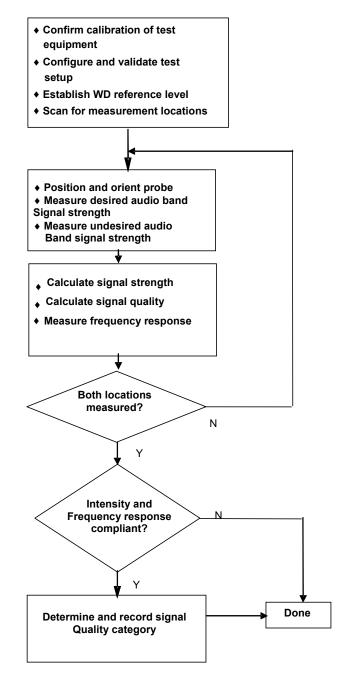
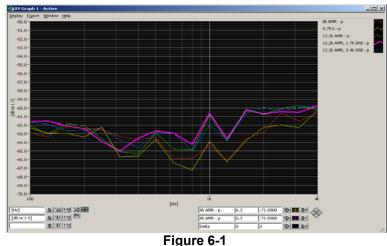


Figure 5-16 C63.19 T-Coil Signal Test Process

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6. FCC 3G MEASUREMENTS



AMR at 12.2kbps, 13.6kbps SRB was used for the testing as the worst-case configuration for the handset. See below plot for ABM noise comparison between vocoder rates:

UMTS Audio Band Magnetic Noise

I. ABM Measurements

Table 6-1 FCC 3G ABM Measurements for ZNFB460

ABM2 Pre-Test (dBA/m), A, HBI

AMR 12.2kbps	AMR 7.95kbps	AMR 4.75kbps	Orientation	Channel
-59.73	-60.82	-61.24	Radial	4132

ABM1 Pre-Test (dBA/m)

AMR 12.2kbps	AMR 7.95kbps	AMR 4.75kbps	Orientation	Channel
-7.990	-8.140	-8.360	Radial	4132

· Mute on; Backlight on; Max Volume, Max Contrast

UMTS: TPC="All 1s";



Figure 6-2 Audio Band Magnetic Curve Measurement Block Diagram

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7. TEST SUMMARY

I. **T-Coil Test Summary**

Table of Results for GSM								
C63.19 Sec.	Mode	Band	Test Description	Minimum Limit*	Measured	Verdict		
				dBA/m	dBA/m	PASS/FAIL		
8.3.1			Intensity, Axial	-18	0.2	PASS		
8.3.1			Intensity, Radial	-18	-8.2	PASS		
8.3.4	GSM	Cellular	Signal-to-Noise/Noise, Axial	20	40.8	PASS		
8.3.4			Signal-to-Noise/Noise, Radial	20	44.4	PASS		
8.3.2			Frequency Response, Axial	0	2.0	PASS		
			-					
8.3.1			Intensity, Axial	-18	0.1	PASS		
8.3.1			Intensity, Radial	-18	-8.2	PASS		
8.3.4	GSM	M PCS	Signal-to-Noise/Noise, Axial	20	48.0	PASS		
8.3.4			Signal-to-Noise/Noise, Radial	20	44.7	PASS		
8.3.2			Frequency Response, Axial	0	2.0	PASS		

Table 7-1

Table 7-2 Table of Results for UMTS

C63.19 Sec.	Mode	Band	Test Description	Minimum Limit*	Measured	Verdict	
				dBA/m	dBA/m	PASS/FAIL	
8.3.1			Intensity, Axial	-18	0.7	PASS	
8.3.1			Intensity, Radial	-18	-8.0	PASS	
8.3.4	UMTS	Cellular	Signal-to-Noise/Noise, Axial	20	56.3	PASS	
8.3.4			Signal-to-Noise/Noise, Radial	20	51.6	PASS	
8.3.2			Frequency Response, Axial	0	2.0	PASS	
8.3.1			Intensity, Axial	-18	0.7	PASS	
8.3.1			Intensity, Radial	-18	-8.0	PASS	
8.3.4	UMTS	IMTS PCS	Signal-to-Noise/Noise, Axial	20	56.2	PASS	
8.3.4			Signal-to-Noise/Noise, Radial	20	51.7	PASS	
8.3.2			Frequency Response, Axial	0	2.0	PASS	

Note: The above summary table represents the worst-case numerical values according to configurations in Tables 7-4 and 7-5.

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	Volume Setting	Cellular		PCS			
		Axial	Radial	Axial	Radial		
Freq. Response Margin		PASS	N/A	PASS	N/A		
Magnetic Intensity Verdict	Maximum	PASS	PASS	PASS	PASS		
FCC SNR Verdict		PASS	PASS	PASS	PASS		

Table 7-3 **Consolidated Tabled Results**

Note: Result shown is for T-coil category only.

II. **Raw Handset Data**

Raw Data Results for GSM								
	Volume	Cellular Band						
	Volume		Axial			Radial		
		128	190	251	128	190	251	
ABM1, dBA/m		0.25	0.17	0.20	-8.20	-8.17	-8.20	
ABM2, dBA/m		-44.53	-42.50	-40.57	-55.53	-53.70	-52.60	
Ambient Noise, dBA/m		-61.52	-61.52	-61.52	-62.15	-62.15	-62.15	
Freq. Response Margin (dB)	Maximum	2.00	2.00	2.00	N/A	N/A	N/A	
S+N/N (dB)		44.78	42.67	40.77	47.33	45.53	44.40	
S+N/N per orientation (dB)			40.77			44.40		
	Volume	PCS Band						
			Axial		Radial			
		512	661	810	512	661	810	
ABM1, dBA/m		0.13	0.19	0.18	-8.17	-8.15	-8.16	
ABM2, dBA/m		-47.92	-47.82	-48.19	-57.23	-57.57	-52.85	
Ambient Noise, dBA/m		-61.52	-61.52	-61.52	-62.15	-62.15	-62.15	
Freq. Response Margin (dB)	Maximum	2.00	2.00	2.00	N/A	N/A	N/A	
S+N/N (dB)		48.05	48.01	48.37	49.06	49.42	44.69	
S+N/N per orientation (dB)			48.01			44.69		
T-coil Coordinates (cm)	[x,y] from bottom left	2.6, 2.6			2.6, 3.5			

Table 7-4

Notes:

- 1. Power Configuration: GSM850: PCL=5, GSM1900: PCL=0
- Phone Condition: Mute on; Backlight on; Max Volume, Max Contrast
 Vocoder Configuration: EFR (GSM)
 'Radial' orientation refers to radial transverse.

- 5. Speech Signal: ITU-T P.50 Artificial Voice

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	Volume			Cell.	Band		
	Volume		Axial			Radial	
		4132	4183	4233	4132	4183	4233
ABM1, dBA/m		0.73	0.79	0.80	-8.01	-8.00	-8.00
ABM2, dBA/m		-55.59	-55.73	-55.66	-59.63	-59.76	-59.73
Ambient Noise, dBA/m		-61.52	-61.52	-61.52	-62.15	-62.15	-62.15
Freq. Response Margin (dB)	Maximum	2.00	2.00	2.00	N/A	N/A	N/A
S+N/N (dB)		56.32	56.52	56.46	51.62	51.76	51.73
S+N/N per orientation (dB)			56.32			51.62	
	Volume	PCS Band					
			Axial			Radial	-
		9262	9400	9538	9262	9400	9538
ABM1, dBA/m		0.84	0.70	0.68	-7.99	-8.00	-8.00
ABM2, dBA/m		-55.57	-55.63	-55.50	-59.79	-59.69	-59.73
Ambient Noise, dBA/m		-61.52	-61.52	-61.52	-62.15	-62.15	-62.15
Freq. Response Margin (dB)	Maximum	2.00	2.00	2.00	N/A	N/A	N/A
S+N/N (dB)		56.41	56.33	56.18	51.80	51.69	51.73
S+N/N per orientation (dB)			56.18			51.69	
T-coil Coordinates (cm)	[x,y] from bottom left		2.6, 2.6		2.6, 3.5		

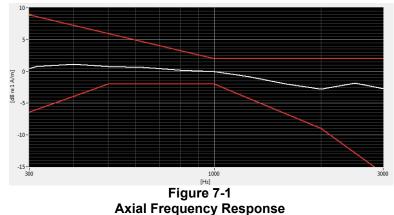
Table 7-5 **Raw Data Results for UMTS**

Notes:

- Power Configuration: UMTS: TPC="All 1s"
 Phone Condition: Mute on; Backlight on; Max Volume, Max Contrast
- Vocoder Configuration: AMR 12.2 kbps (UMTS)
 'Radial' orientation refers to radial transverse.
 Speech Signal: ITU-T P.50 Artificial Voice

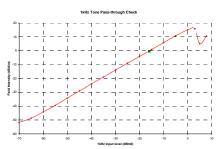
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III. Frequency Response Graph



Note: User T-coil Mode (**Settings→Accessibility→Hearing Aid**) was set to ON for Frequency Response compliance. This frequency response represents the worst-case ABM2 test configuration according to Tables 7-4 and 7-5.

IV. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -16 dBm0 for GSM and UMTS. This measurement was taken in the axial configuration above the maximum location.

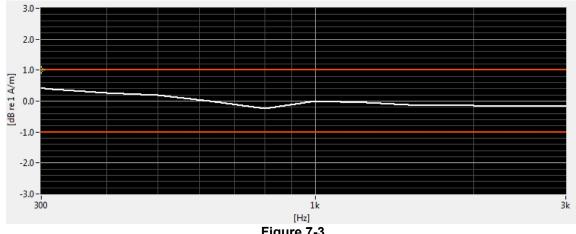
V. Undesirable Audio Magnetic Band Plot (ABM2)



Note: This plot represents the data from the location/configuration resulting in the highest ABM2 result shown in Tables 7-4 and 7-5.

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VI. T-Coil Validation Test Results



[Hz] Figure 7-3 Helmholtz Coil Validation for Frequency Response

Table 7-6
Helmholtz Coil Validation Table of Results

Item	Target	Result	Verdict				
Signal Validation							
Frequency Response, from limits	0 ± 0.5 dB	0.30	PASS				
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-9.741	PASS				
Noise Validation	Noise Validation						
Axial Environmental Noise	< - 58 dBA/m	-61.52	PASS				
Radial Environmental Noise	< - 58 dBA/m	-62.15	PASS				

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8. MEASUREMENT UNCERTAINTY

			distribution	Divisor	Standard uncertainty	Uncertainty (dB)
7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
4.7%	0.20	Specification	Rectangular	1.73	2.7%	
12.2%	0.50	Specification	Rectangular	1.73	7.0%	
10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
12.2%	0.50	Specification	Rectangular	1.73	7.0%	
2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
2.8%	0.12	Specification	Rectangular	1.73	1.6%	
5.0%	0.21	Specification	Rectangular	1.73	2.9%	
5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty, uc (k=1)						0.71
Expanded uncertainty (k=2), 95% confidence level						1.31
	10.0% 12.2% 2.4% 2.8% 5.0% 5.0% 9.0% 1.0% uc (k=1)	10.0% 0.41 12.2% 0.50 2.4% 0.10 2.8% 0.12 5.0% 0.21 5.0% 0.37 1.0% 0.04 uc (k=1) 0	10.0% 0.41 Uncertainty 12.2% 0.50 Specification 2.4% 0.10 Std. Dev. 2.8% 0.12 Specification 5.0% 0.21 Specification 5.0% 0.21 Std. Dev. 9.0% 0.37 Std. Dev. 1.0% 0.04 Specification	10.0%0.41UncertaintyRectangular12.2%0.50SpecificationRectangular2.4%0.10Std. Dev.Normal k=12.8%0.12SpecificationRectangular5.0%0.21SpecificationRectangular5.0%0.21Std. Dev.Normal k=19.0%0.37Std. Dev.Normal k=11.0%0.04SpecificationRectangularuc (k=1)Image: state s	10.0% 0.41 Uncertainty Rectangular 1.73 12.2% 0.50 Specification Rectangular 1.73 2.4% 0.10 Std. Dev. Normal k=1 1.00 2.8% 0.12 Specification Rectangular 1.73 5.0% 0.21 Specification Rectangular 1.73 5.0% 0.21 Specification Rectangular 1.73 5.0% 0.21 Std. Dev. Normal k=1 1.00 9.0% 0.37 Std. Dev. Normal k=1 1.00 1.0% 0.04 Specification Rectangular 1.73 uc (k=1) uc (k=1) uc (k=1) uc (k=1) uc (k=1)	10.0% 0.41 Uncertainty Rectangular 1.73 5.8% 12.2% 0.50 Specification Rectangular 1.73 7.0% 2.4% 0.10 Std. Dev. Normal k=1 1.00 2.4% 2.8% 0.12 Specification Rectangular 1.73 1.6% 5.0% 0.21 Specification Rectangular 1.73 2.9% 5.0% 0.21 Std. Dev. Normal k=1 1.00 5.0% 9.0% 0.37 Std. Dev. Normal k=1 1.00 9.0% 1.0% 0.04 Specification Rectangular 1.73 0.6% uc (k=1) 17.7% 10.0%

Table 8-1 Uncertainty Estimation Table

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.

2. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in

NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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EQUIPMENT LIST 9.

Equipment List								
Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number		
Control Company	36934-158	Wall-Mounted Thermometer	4/29/2014	Biennial	4/29/2016	122014488		
Listen	SoundConnect	Microphone Power Supply	2/17/2014	Annual	2/17/2015	0899-PS150		
Listen	SoundCheck	Acoustic Analyzer System	10/11/2013	Annual	10/11/2014	04-06-5876-SC2850		
NI	4474	Data Acquisition Card	N/A		N/A	N/A		
Rohde & Schwarz	CMU200	Base Station Simulator	4/24/2014	Annual	4/24/2015	836371/0079		
Seekonk	NC-100	Torque Wrench (8" lb)	11/29/2011	Triennial	11/29/2014	21053		
TEM	Axial T-Coil Probe	Axial T-Coil Probe	2/17/2014	Annual	2/17/2015	TEM-1123		
TEM	Radial T-Coil Probe	Radial T-Coil Probe	2/17/2014	Annual	2/17/2015	TEM-1129		
TEM	Helmholtz Coil	Helmholtz Coil	8/6/2013	Annual	8/6/2014	SBI 1052		
TEM		HAC System Controller with Software	N/A		N/A	N/A		
TEM		HAC Positioner	N/A		N/A	N/A		

Table 9-1

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10. CALIBRATION CERTIFICATES

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		al T Coil Probe	CONSULTIN	in c	
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	Customer:	JUSTIN CHAC)		
	Company: Address:	PCTEST ENG 6660-B DOBBI		B	
	Address.	COLUMBIA	N KOMD	MD 21045	1923
This document c submitter. West Caldwell C	te of Standards and Technol ertifies that the instrument Calibration Laboratories Pro	met the following s ocedure No. A			
Upon receipt for	Calibration, the instrumen	t was found to be:			
V V	Within (X) see atta	ached Report of Ca	libration.		(Car
the tolerance of	the indicated specification.				1000 1000 1000 1000 1000 1000 1000 100
West Caldwell C 10012-1 MIL-ST	Calibration Laboratories' ca CD-45662A, ANSI/NCSL Z5	libration control sy 40-1, IEC Guide 25	stem meets the 5, ISO 9001:20	e requirements, ISO 108 and ISO 17025.	
				2/22/14	Ì
Note: With this Cert	lificate, Report of Calibration is in	ciuded.	Approved	oy:	
Calibration Date	e: 17-Feb-14			F/	
Certificate No:	23889 - 1		Felix Chri	stopher (QA Mgr.)	
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Calibration Lab. Cert. # 1533.01

REPORT OF CALIBRATION

ora		Company : PCTEST Engineering Lab.				I. D. No: 8	30582
	ation results:				Before data:	After data: .	
		Sensitivity measured v	with Helmhol	tz Coil			
		Helmholtz Coil;			Before &	& after data same: .	X
		ber of turns on each coil;		No.			
		is of each coil, in meters;		m A	Laboratory E		с
		in the coils, in amperes.;			Ambient Temperat		6 RH
		Helmholtz Coil Constant;	7.09	A/m/V	Ambient Humic	,.	a Rh Ra
	Helmi	holtz Coil magnetic field;	5.98	A/m	Ambient Press		ra
					Calibration D		
		Probe Sensitivity at		Hz. dBV/A/i	Re-calibration D		1
		was	-60.20 0. 9 77	mV/A/m	Report Numl Control Numl		'1
		Probe resistance		Ohms	Conser Nam		
	above listed i				manufacturer's specificati	ons.	
		ble through NIST test numb		,28770			
хp	panded uncertainty	of calibration: 0.30dB at 95%	6 confidence lev	el with a cove	age factor of k=2.		
h ı	represents Probes	Frequency Response.					
				Axial Pro	e Response	-Measured Probe	
20	.0						
1	5						
1(0						
ę	5						
(0						
-{	5						
-1(0						
-1	5						
-20							
-20	100		Fr	eq. (Hz)	000		10000
							• • • • • • • • • • • • • • • • • • • •
		ries Inc. procedure :	using calibra	ation proce	dure documented in West Caldv Rev. 7.0 Jan. 24, 2		HCATEMO
		d by West Caldwell Calibra	tion I aboratorie	es Inc. under	,		
					SL Z540-1, (MIL-STD-45662A) and ISC	0 9001:2008, ISO 1702	5
						Az	
		al. Date: 17-Feb-2014			Measurements performed	•	
	ated on WCCL sys	•••				Felix Christop	
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HCATEMC_TEM-1123_Feb-17-2014

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe

for Model No.: Axial T Coil Probe

Serial No.: TEM-1123

Company : PCTEST Engineering Lab.

Test	Function	Tolera	Measured values			
				Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.20		
		·	dB			
2.0	Probe Level Linearity		6	6.03		
		Ref. (0 dB)	0	0.00		
			-6	-6.02		
			-12	-12.05		
			Hz			
3.0	Probe Frequency Response		100	-19.9		
			126	-17.9		
			158	-16.0		
			200	-13.9		
			251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		
			631	-4.0		
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	7.9		
			3162	9.9		
			3981	11.9		
			5012	13.9		
			6310	15.9		
			7943	18.0		
			10000	20.2		

Instruments used for calibration	on:		Date of Cal.	Traceablity No.	Due Date
HP	34401A	S/N 36064102	8-Oct-2013	,287708	8-Oct-2014
HP	34401A	S/N 36102471	8-Oct-2013	,287708	8-Oct-2014
HP	33120A	S/N 36043716	8-Oct-2013	,287708	8-Oct-2014
B&K	2133	S/N 1583254	9-Dec-2012	683/281764-12	10-Dec-2013

Cal. Date: 17-Feb-2014 Tested by: Felix Christopher

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Calibrated on WCCL system type 9700

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Cart	ficate	f Cal	ibu ation	
Ceru	incate o	ICa	libration	
		for		
	Radial T Manufactured by:	Coil Probe	CONSULTING	
	Model No:	Radial	T Coil Probe	
	Serial No: Calibration Recall	TEM-1 No: 23889	129	
		mitted By:		
		JUSTIN CHAO PCTEST ENGIN	FEDINCLAR	
	Address: 0	6660-B DOBBIN	ROAD	
	,	COLUMBIA	MD 21045	
National Institute of St	andards and Technology	or to accepted va	ion using standards traceable to slues of natural physical constant cification upon its return to the	R.*
West Caldwell Calibra	tion Laboratories Proced	ure No. Radi	al T C TEM	143
Upon receipt for Calib	ration, the instrument wa	s found to be:		
Within	(X) see attache	ed Report of Cali	bration.	6
the tolerance of the ind	licated specification.			
			em meets the requirements, ISO	
10012-1 MIL-STD-456	62A, ANSI/NCSL Z540-1	, IEC Guide 25,	ISO 9001:2008 and ISO 17025.	
			2/22/14	e
Note: With this Certificate,	Report of Calibration is includ	ed.	Approved by:	
Calibration Date:	17-Feb-14		FC	
Certificate No:	23889 - 2		Felix Christopher (QA Mgr.)	
QA Doc. #1051 Rev. 2.0 10/1/01	Certificate	Page 1 of 1	ISO/IEC 17025:2005	(
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	Laboratories, Ir	nc.	ACCREDITED	

PCT# 80583

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HCRTEMC_TEM-1129_Feb-17-2014



1575 State Route 96, Victor NY 14564



Calibration Lab. Cert. # 1533.01

REPORT OF CALIBRATION

TEM Consul	ting LP Radial T Coil P	robe	Model	No.: Radial T Coil Probe	Serial No.: 1	ГЕМ-1129
ompany : PCTE	ST Engineering Lab.				I. D. No: 8	30583
oration results:				Before data:	After data: .	
Probe	Sensitivity measured with Helmholtz Coil;	th Helmhol	tz Coil	Before &	after data same: .	x
	ber of turns on each coil;	10	No.			
	us of each coil, in meters;	0.204	m	Laboratory Env		c
	in the coils, in amperes.;	0.09 7.09	A A/m/V	Ambient Temperature		% RH
	Helmholtz Coil Constant;	5.98	A/m	Ambient Humidit	•	«Pa
nem	holtz Coil magnétic field;	5.90	Am	Calibration Date		Ira
	Broke Constitutiv et	4000	Hz.			
	Probe Sensitivity at was	1000 -60.38	пz. dBV/A/m	Re-calibration Due Report Numbe		-2
	1140	0.957	mV/A/m	Control Numbe		-
	Probe resistance	900	Ohms			
expanded uncertainty	ble through NIST test number of calibration: 0.30dB at 95% c Frequency Response.		,287708 el with a coveraç	ge factor of k=2.		
			Radial Probe	Response Mea	asured Probe Resp.	
20						
15						
10						
5						<u>}</u>
0						
-5						
10						
15						
-20 100		Fre	əq.(Hz) 100	00	······································	10000
bration Laborato pration was performe ded to implement th	ries Inc. procedure : d by West Caldwell Calibratio	n Laboratorie	Inc. under O	re documented in West Caldwe Rev. 7.0 Jan. 24, 20 perating Procedures . 2540-1, (MIL-STD-45662A) and ISO 9 Measurements performed b	14 Doc. # 1038 9001:2008, ISO 1702: <i>Ar</i>	
orated on WCCL sy					Felix Christop	her
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FCC ID:ZNFB460	CAPCTEST	HAC (T-COIL) TEST REPORT	🕒 LG	Reviewed by: Quality Manager	
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West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record for

TEM Consulting LP Radial T Coil Probe

Model No.: Radial T Coil Probe

Serial No.: TEM-1129

Company : PCTEST Engineering Lab.

Test	Function	Tolerance		Measured values		
	- 			Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.38		
			dB			
2.0	Probe Level Linearity		6	6.04		
		Ref. (0 dB)	0	0.00		
			-6	-6.03		
			-12	-12.05		
			Hz			
3.0	Probe Frequency Response		100	-19.9		
			126	-17.9		
			158	-15.9		
			200	-13.9		
			251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		
			631	-4.0		
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	7.9		
			3162	9.9		
			3981	11.9		
			5012	13.9		
			6310	16.0		
			7943	18.0		
		·	10000	20.2		

Instruments used for calibration	:		Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N 36064102	8-Oct-2013	,287708	8-Oct-2014
HP	34401A	S/N 36102471	8-Oct-2013	,287708	8-Oct-2014
HP	33120A	S/N 36043716	8-Oct-2013	,287708	8-Oct-2014
B&K	2133	S/N 1583254	9-Dec-2012	683/281764-12	10-Dec-2013

Cal. Date: 17-Feb-2014

Calibrated on WCCL system type 9700

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Tested by: Felix Christopher

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11. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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